

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ANDREW ET AL.	
		Examiner Alicia Baturay	Art Unit 2155	Page 1 of 4

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		Examiner Alicia Baturay	Art Unit 2155	Page 2 of 4

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		Examiner Alicia Baturay	Art Unit 2155	Page 3 of 4

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		Examiner Alicia Baturay	Art Unit 2155	Page 4 of 4

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